	Se	arcn	notes	
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/505,417	KANETA ET AL.	
Examiner	Art Unit	
Cynthia Lee	1745	

	SEARCHED		
Class	Subclass	Date	Examiner
429	178	11/22/2005	CL
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEAR (INCLUDING S	CH NOTES EARCH STRATE	GY)
	DATE	
inventor search	11/22/20	05 CL
intl search report	11/22/20	05 CL
EAST search	11/22/20	05 CL